## Quiz 2 XRD 4/5/01

A change in momentum for a charged particle is often used as a source for x-rays.

- a) **Sketch** an x-ray tube showing:
  - -the source and kind of charged particles,
  - -the mechanism for control of momentum of the particles
  - -the mechanism for change in momentum of the particles
  - -and the necessary parts to achieve and control this process.
- b) **Make a plot** of intensity of x-rays versus wavelength for a copper anode for 1kV, 5kV, 20kV and 40kV
  - -Give a function for the short wavelength limit.
  - -Give a function for the white radiation intensity.
  - -Give a function for the characteristic radiation intensity.
  - -Show the wavelengths of the characteristic peaks.
- c) Describe the mechanism for formation of the 5kV curve in part b.-Why isn't the radiation a single wavelength?
- d) **Describe** the mechanism for formation of the part of the 40kV radiation that differs from your answer to part c.
- e) -What material could be used to filter the 40kV radiation for an XRD measurement?
  -Explain your choice of this material.
  -How does the absorption coefficient depend on Z and ?
  -How would you decide the thickness for this filter?

## Answers: Quiz 2 XRD 4/5/01

a) -Source is a filament and kind is electrons.
-control of momentum is a high voltage drop (30 to 40kV)
-Mechanism for change is a piece of metal which serves as the anode, Cu or Mo.
-To control you need cooling water and a high vacuum 10<sup>-7</sup> Torr.

b)  $_{swl} = 12.4/kV$  where kV is the voltage drop in kV across the tube.  $I_{Bremstralung} = K i Z V^2$   $I_{Characteristic} = K i (V-V_K)^{1.5}$   $Cu_K$  radiation occurs at 1.54Å  $Cu_K$  radiation at 1.41Å The critical voltage to observe characteristic peaks is 9kV for Cu.

- c) White radiation represents a distribution of events of variable energy. The highest energy corresponds with a direct hit on a Cu atom by the electron in the tube. This is the source of  $_{swl} = 12.4/kV$ . Other more probable events involve partial collision where lower energy is involved.
- d) Above the critical voltage of 9kV electrons from the K shell can be removed. Filling of these orbitals by L or M orbital electrons results in quantized energy release corresponding to the difference in energy between L or M orbitals and the K orbital. These correspond to the K and K peaks observed in the 40kV spectrum.
- e) Nickel is used (Z = 28) for Cu radiation (Z = 29) since the critical energy to remove the K shell electrons matches the peak for Cu. The absorption coefficient depends on Z<sup>3</sup> and I<sup>3</sup>, so there is a fairly sharp valley in absorption coefficient versus wavelength near the Cu<sub>K</sub> peak at 1.54Å for a Nickel filter. To decide the thickness of the Ni filter you would use Beer's Law, I = I<sub>0</sub> exp(- $\mu$ t), where t is the thickness and the value for  $\mu$  for Ni at 1.54 and 1.41Å. A fixed amount of attenuation of the two peaks would be chosen according to the resolution desired in the XRD measurement, typically I<sub>CuK</sub> /I<sub>CuK</sub> = 0.99 would be a good choice. So 0.99 = exp(-t( $\mu \mu$ )) or t = ln(0.99)/( $\mu \mu$ ).